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iee Cnf	IEE Conference Proceeding		Fox, R.M.; Circuits and Systems, 1995. ISCAS '95., 1995 IEEE International Symposium
IEEE STO	IEEE Standard		Volume 1, 28 April-3 May 1995 Page(s):109 - 112 vol.1 Digital Object Identifier 10.1109/ISCAS.1995.521463
			AbstractPlus Full Text: PDF(336 KB) IEEE CNF
		n	2. Characteristic ranges for LSA oscillation Harrison, R.I.; Denker, S.P.; Hadley, M.L.; Electron Devices, IEEE Transactions on Volume 15, Issue 10, Oct 1968 Page(s):792 - 793
			AbstractPlus Full Text: PDF(328 KB) IEEE JNL
			 Performance and optimization of Gunn self-oscillating mixer Krasavin, J.; Hinrikus, H.; Microwave and Guided Wave Letters, IEEE [see also IEEE Microwave and Will Components Letters] Volume 5, Issue 6, June 1995 Page(s):177 - 179 Digital Object Identifier 10.1109/75.386123
			AbstractPlus Full Text: PDF(180 KB) ISSE JNL
		m	4. Tunnel diodes for low noise amplification Armstrong, L.; Electron Devices Meeting, 1961 International Volume 7, 1961 Page(s):62 - 62
			AbstractPlus Full Text: PDF(58 KB) IEEE CNF
		r	 Broadband, robust, low profile monopole incorporating top loading, diele and a distributed capacitive feed mechanism McLean, J.; Foltz, H.; Crook, G.; Antennas and Propagation Society International Symposium, 1999. IEEE Volume 3, 11-16 July 1999 Page(s):1562 - 1565 vol.3 Digital Object Identifier 10.1109/APS.1999.788242

6. Fuzzy modeling of photovoltaic panel equivalent circuit

AbstractPlus | Full Text: PDF(172 KB) IEEE CNF

Elhagry, M.T.; Elkousy, A.A.T.; Saleh, M.B.; Elshatter, T.F.; Abou-Elzahab, E.N. Circuits and Systems, 1997. Proceedings of the 40th Midwest Symposium on Volume 1, 3-6 Aug. 1997 Page(s):60 - 63 vol.1 Digital Object Identifier 10.1109/MWSCAS.1997.666033

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7. Active plasma source formation in the MAP diode

Lamppa, K.P.; Stinnett, R.W.; Renk, T.J.; Crawford, M.T.; Greenly, J.B.; Pulsed Power Conference, 1995. Digest of Technical Papers. Tenth IEEE Inter Volume 1, 3-6 July 1995 Page(s):649 - 654 vol.1 Digital Object Identifier 10.1109/PPC.1995.596774

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L2	6	"716"/\$.ccls. and ((operating adj3 point) same resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 09:52
L3	4	"6813753".pn. "20040025136"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 10:25
L5	4	"20030204818" "6496962".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 10:36
L6	137	((operating adj3 point) same factor) and timing and resistance	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 10:38
L7	20	"716"/\$.ccls. and (((derat\$3 or scal\$3) adj3 factor) same resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 11:56
L8	1	(((derat\$3 or scal\$3) adj3 factor) same (modified adj2 resistance))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 13:28
9ا	25	(factor same (modified adj2 resistance))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 12:53
L12	. 0	"716"/\$.ccls. and (interpolat\$3 same (modified adj3 resistance))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 12:54
ш3	1	"716"/\$.ccls. and (factor\$3 same (modif\$6 near3 resistance))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 12:56

L14	5	(((derat\$3 or scal\$3) adj3 factor) same (modif\$6 near3 resistance))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 12:56
L15	58	("716"/\$.ccls. or "714"/\$.ccls. or "703"/\$.ccls.) and ((operating adj3 (point or condition)) same resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 13:24
L16	1	((modified adj3 resistance) same factor).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 13:25
L17	8	((first adj2 operating) and (second adj2 operating) and modified and analysis).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 13:27
L18	10	((performance with difference) and modified and analysis).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 13:28
L19	0	(((derat\$3 or scal\$3) adj3 factor) and (modified adj2 resistance)). CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 13:29
S1	1	"716"/\$.ccls. and (derat\$3 with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/30 07:50
S3	160	"716"/\$.ccls. and (factor with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/30 09:22
S4	53	"716"/\$.ccls. and ((derat\$3 or scal\$3) with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/03 15:41
S7	5	"716"/\$.ccls. and ((operating adj2 point) same resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 09:48

S8	22	"716"/\$.ccls. and ((operating adj2 (point or condition)) same resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/30 09:40
S9	53	("716"/\$.ccls. or "714"/\$.ccls. or "703"/\$.ccls.) and ((operating adj2 (point or condition)) same resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 12:57
S10	2	"6308309".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/30 10:06
S11	2	("716"/\$.ccls. or "714"/\$.ccls. or "703"/\$.ccls.) and (apply\$3 with factor with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/30 10:09
S12	95	("716"/\$.ccls. or "714"/\$.ccls. or "703"/\$.ccls.) and ((derat\$3 or scal\$3) with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/30 11:03
S16	6	("6412100" "6898769" "6526554").pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/02 14:58
S18	1158	"716"/6.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/03 15:38
S19	1178	"716"/1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/03 15:39
S22	13	"716"/\$.ccls. and (((derat\$3 or scal\$3) adj2 factor) with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/03 10:42
S23	371	(((derat\$3 or scal\$3) adj2 factor) with resistance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/03 15:43

S24 13 wen-huajun.in. US-PGPUB; OR ON USPAT; EPO; JPO; DERWENT; IBM TDB
